Search Notes		
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_	Application/Control No.	Applicant(s)/Patent under Reexamination	
	09/991,616	ZHANG ET AL.	
	Examiner	Art Unit	
	Gerald Gauthier	2645	

	SEAR	CHED	
Class	Subclass	Date	Examiner
455	406	5/16/2005	G.G.
455	412.1		
455	414.4		
455	417		

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEAF (INCLUDING S	RCH NOTES SEARCH STRATEG	Y)
	DATE	EXMR
EAST	5/16/2005	G.G.